Sheet 1 of 2 ' '										
FORM PTO 1449 (modified)				ATTY DOCKET NO. SERIAL 2003-1361 NEW			NO.			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT Minoru TERANO et al.						
(Use several sheets if necessary) Date Submitted to PTO: September 24, 2003				FILING DATE			GROUP 1713			
Date Submitted to PTO: September 24, 2003 September 24, 2003 / / / 3 U.S. PATENT DOCUMENTS								·		
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLAS		SS	SUBCLASS	FILING DATE IF APPROPRIATE		
F	AA	5,362,782	11/1994	McCullough, Jr., et al.						
F	АВ	5,741,862	4/1998	Muller et al.						
FI	AC	6,211,300 B1	4/2001	Terano et al.						
F	AD	4,006,116	2/1997	Dominguez						
FOREIGN PATENT DOCUMENTS										
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS		SUBCLASS	TRANSLATION YES NO		
F	AE	05-331327	12/1993	Japan						
	AF	06-145268	5/1994	Japan						
	AG	56-072042	6/1981	Japan						
	АН	57-063350	4/1982	Japan						
	AI	50-14742	2/1975	Japan						
	A)	52-65551	5/1977	Japan		•				
	AK	58-206644	12/1983	Japan						
	AL	58-215446	12/1983	Japan						
	AM	61-014248	1/1986	Japan						
	AN	08-269258	10/1996	Japan						
	AO	07-173233	7/1995	Japan						
	АР	60-190409	9/1985	Japan						
A	AQ	703253	3/1996	Europe						
OTHER DOCUMENT(S) (Including Author, Title, Date, Perlinent Pages, Etc.)										
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy this form with next communication to applicant.

Sheet 2 of 2	t:										
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: September 24, 2003				ATTY DOCKET NO. SERIAL 2003-1361 NEW							
				APPLICANT Minoru TERANO et al.							
				FILING DATE September 24, 2003			GROUP 1713				
U.S. PATENT DOCUMENTS											
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			FORI	EIGN PATENT	DOCUMENTS	τ		r			
		DOCUMENT NUMBER	DATE	С					TRANSLA YES	ATION NO	
M	AJ	09-087343	3/1997		Japan 						
F	AK	09-241334	9/1997		Japan						
	AL					<u> </u>					
	AM										
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		OTHER	DOCUMENT(S) (ncluding Auth	or, Title, Date, Pertii	nent Page:	s, Etc.)				
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